Complementary Bias Resistor Transistors NPN - R1=47 k Ω , R2=47 k Ω PNP - R1=2.2 k Ω , R2=47 k Ω NPN and PNP Transistors with Monolithic Bias Resistor Network

This series of digital transistors is designed to replace a single device and its external resistor bias network. The Bias Resistor Transistor (BRT) contains a single transistor with a monolithic bias network consisting of two resistors; a series base resistor and a base-emitter resistor. The BRT eliminates these individual components by integrating them into a single device. The use of a BRT can reduce both system cost and board space.

Features

- Simplifies Circuit Design
- Reduces Board Space
- Reduces Component Count
- NSV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS

 $(T_A = 25^{\circ}C, common for Q_1 (PNP), unless otherwise noted)$

Rating	Symbol	Max	Unit
Collector-Base Voltage	V _{CBO}	50	Vdc
Collector-Emitter Voltage	V_{CEO}	50	Vdc
Collector Current – Continuous	I _C	100	mAdc
Input Forward Voltage	V _{IN(fwd)}	12	Vdc
Input Reverse Voltage	V _{IN(rev)}	5	Vdc

MAXIMUM RATINGS

(T_A = 25°C, common for Q₂ (NPN), unless otherwise noted)

Rating	Symbol	Max	Unit			
Collector-Base Voltage	V _{CBO}	50	Vdc			
Collector-Emitter Voltage	V_{CEO}	50	Vdc			
Collector Current – Continuous	I _C	100	mAdc			
Input Forward Voltage	V _{IN(fwd)}	40	Vdc			
Input Reverse Voltage	V _{IN(rev)}	10	Vdc			

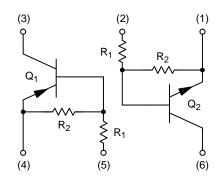
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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PIN CONNECTIONS



MARKING DIAGRAM



SOT-363 CASE 419B



AJ = Specific Device Code

M = Date Code*
= Pb-Free Package

(Note: Microdot may be in either location)

*Date Code orientation may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping†
NSVMUN531335DW1T1G	SOT-363 (Pb-Free)	3000 / Tape & Reel
NSVMUN531335DW1T3G	l	10000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Characteristic	Sym	bol Max	Unit			
MUN531335DW1 (SOT-363) ONE JUNCTION HEATED						
Total Device Dissipation $T_A = 25^{\circ}C \qquad \text{(Note 1)}$ (Note 2) Derate above 25°C \text{(Note 1)} (Note 2)	P _E	187 256 1.5 2.0	mW mW/°C			
Thermal Resistance, (Note 1) Junction to Ambient (Note 2)	$R_{\theta_{\lambda}}$	JA 670 490	°C/W			
MUN531335DW1 (SOT-363) BOTH JUNCTION HEATEI	O (Note 3)					
Total Device Dissipation $T_A = 25^{\circ}C \qquad \text{(Note 1)}$ (Note 2) Derate above 25°C \text{(Note 1)} (Note 2)	P _t	250 385 2.0 3.0	mW mW/°C			
Thermal Resistance, Junction to Ambient (Note 1) (Note 2)	$R_{\theta_{\lambda}}$	JA 493 325	°C/W			
Thermal Resistance, Junction to Lead (Note 1) (Note 2)	$R_{\theta_{\lambda}}$	JL 188 208	°C/W			
Junction and Storage Temperature Range	T _J , 1	Γ _{stg} −55 to +150	°C			

FR-4 @ Minimum Pad.
 FR-4 @ 1.0 × 1.0 Inch Pad.
 Both junction heated values assume total power is sum of two equally powered channels.

ELECTRICAL CHARACTERISTICS ($T_A = 25$ °C, common for Q_1 (PNP))

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•			
Collector–Base Cutoff Current $(V_{CB} = 50 \text{ V}, I_E = 0)$	I _{CBO}	_	-	100	nAdc
Collector–Emitter Cutoff Current $(V_{CE} = 50 \text{ V}, I_B = 0)$	I _{CEO}	_	_	500	nAdc
Emitter-Base Cutoff Current (V _{EB} = 6.0 V, I _C = 0)	I _{EBO}	_	_	0.2	mAdc
Collector–Base Breakdown Voltage (I _C = 10 µA, I _E = 0)	V _(BR) CBO	50	_	-	Vdc
Collector–Emitter Breakdown Voltage (Note 4) (I _C = 2.0 mA, I _B = 0)	V _(BR) CEO	50	_	-	Vdc
ON CHARACTERISTICS	•				
DC Current Gain (Note 4) (I _C = 5.0 mA, V _{CE} = 10 V)	h _{FE}	80	140	-	
Collector–Emitter Saturation Voltage (Note 4) (I _C = 10 mA, I _B = 0.3 mA)	V _{CE(sat)}	_	_	0.25	Vdc
Input Voltage (off) $(V_{CE} = 5.0 \text{ V}, I_C = 100 \mu\text{A})$	V _{i(off)}	_	0.6	-	Vdc
Input Voltage (on) $(V_{CE} = 0.2 \text{ V}, I_C = 5.0 \text{ mA})$	V _{i(on)}	_	0.8	_	Vdc
Output Voltage (on) (V _{CC} = 5.0 V, V _B = 2.5 V, R _L = 1.0 k Ω)	V _{OL}	_	_	0.2	Vdc
Output Voltage (off) ($V_{CC} = 5.0 \text{ V}, V_B = 0.5 \text{ V}, R_L = 1.0 \text{ k}\Omega$)	V _{OH}	4.9	-	-	Vdc
Input Resistor	R1	1.5	2.2	2.9	kΩ
Resistor Ratio	R ₁ /R ₂	0.038	0.047	0.056	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulsed Condition: Pulse Width = 300 msec, Duty Cycle ≤ 2%.

ELECTRICAL CHARACTERISTICS (T_A = 25°C, common for Q₂ (NPN))

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>				
Collector-Base Cutoff Current $(V_{CB} = 50 \text{ V}, I_E = 0)$	Ісво	-	-	100	nAdc
Collector-Emitter Cutoff Current $(V_{CE} = 50 \text{ V}, I_B = 0)$	I _{CEO}	_	_	500	nAdc
Emitter-Base Cutoff Current $(V_{EB} = 6.0 \text{ V}, I_C = 0)$	I _{EBO}	-	_	0.1	mAdc
Collector-Base Breakdown Voltage (I _C = 10 μA, I _E = 0)	V _{(BR)CBO}	50	-	_	Vdc
Collector-Emitter Breakdown Voltage (Note 5) (I _C = 2.0 mA, I _B = 0)	V _{(BR)CEO}	50	_	-	Vdc
ON CHARACTERISTICS					
DC Current Gain (Note 5) (I _C = 5.0 mA, V _{CE} = 10 V)	h _{FE}	80	140	_	
Collector-Emitter Saturation Voltage (Note 5) (I _C = 10 mA, I _B = 0.3 mA)	V _{CE(sat)}	-	_	0.25	V
Input Voltage (Off) ($V_{CE} = 5.0 \text{ V}, I_{C} = 100 \mu\text{A}$)	V _{i(off)}	-	1.2	_	Vdc
Input Voltage (On) (V _{CE} = 0.2 V, I _C = 3.0 mA)	V _{i(on)}	_	1.9	_	Vdc
Output Voltage (On) ($V_{CC} = 5.0 \text{ V}$, $V_B = 3.5 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$)	V _{OL}	-	-	0.2	Vdc
Output Voltage (Off) ($V_{CC} = 5.0 \text{ V}, V_B = 0.5 \text{ V}, R_L = 1.0 \text{ k}\Omega$)	V _{OH}	4.9	-	-	Vdc
Input Resistor	R1	32.9	47	61.1	kΩ
Resistor Ratio	R ₁ /R ₂	0.8	1.0	1.2	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulsed Condition: Pulse Width = 300 ms, Duty Cycle \leq 2%.

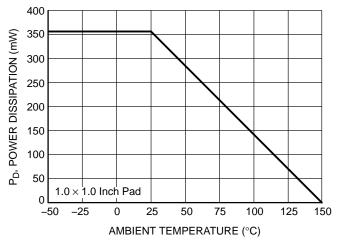


Figure 1. Derating Curve

TYPICAL CHARACTERISTICS - PNP TRANSISTOR

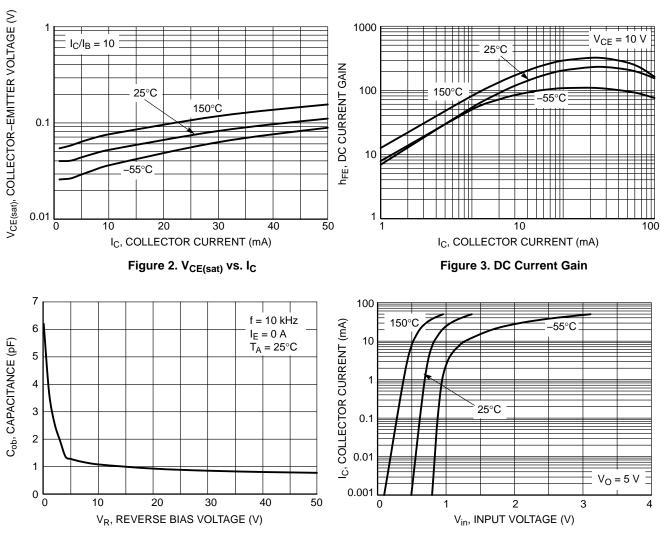


Figure 4. Output Capacitance

Figure 5. Output Current vs. Input Voltage

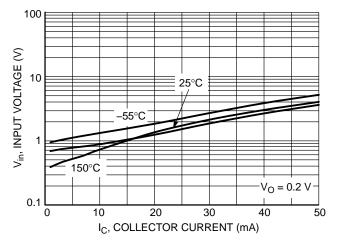


Figure 6. Input Voltage vs. Output Current

TYPICAL CHARACTERISTICS - NPN TRANSISTOR

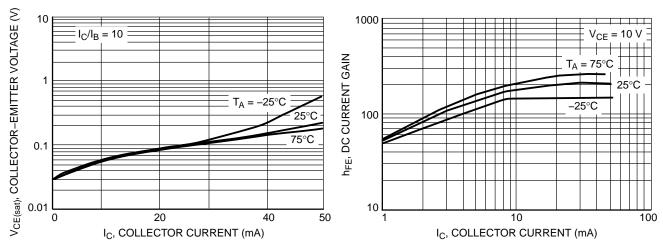


Figure 7. V_{CE(sat)} vs. I_C

Figure 8. DC Current Gain

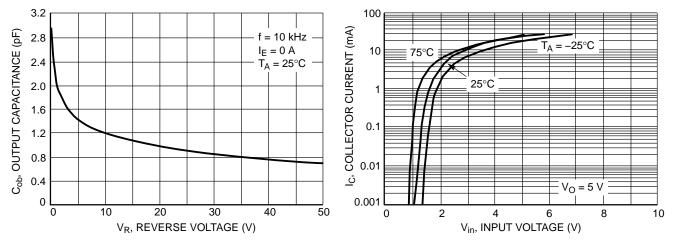


Figure 9. Output Capacitance

Figure 10. Output Current vs. Input Voltage

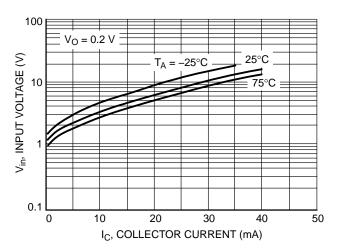
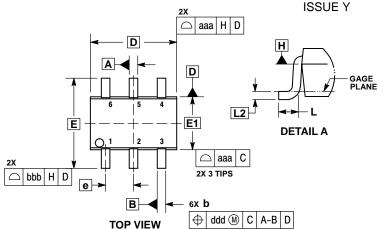


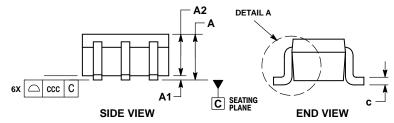
Figure 11. Input Voltage vs. Output Current

PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363

CASE 419B-02





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-
- SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AND DATUM H.
 DATUMS A AND B ARE DETERMINED AT DATUM H.

- DATUMS A AND B ARE DETERMINED AT DATUM H.

 DIMENSIONS b AND 6 APPLY TO THE FLAT SECTION OF THE

 LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.

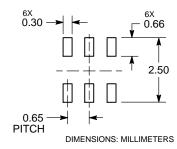
 DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION.

 ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN

 EXCESS OF DIMENSION b AT MAXIMUM MATERIAL CONDI-TION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES				
DIM	MIN	NOM	MAX	MIN	NOM	MAX		
Α			1.10			0.043		
A1	0.00		0.10	0.000		0.004		
A2	0.70	0.90	1.00	0.027	0.035	0.039		
b	0.15	0.20	0.25	0.006	0.008	0.010		
С	0.08	0.15	0.22	0.003	0.006	0.009		
D	1.80	2.00	2.20	0.070	0.078	0.086		
E	2.00	2.10	2.20	0.078	0.082	0.086		
E1	1.15	1.25	1.35	0.045	0.049	0.053		
е	(0.65 BSC			0.026 BSC			
L	0.26	0.36	0.46	0.010	0.014	0.018		
L2		0.15 BSC			0.006 BSC			
aaa	0.15			0.006				
bbb	0.30			0.012				
ccc	0.10			0.004				
ddd		0.10		0.004				

RECOMMENDED SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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